

Search Notes

Application/Control No.

10/667,004

Examiner

Frank W. Lu

Applicant(s)/Patent under
Reexamination

CHAN ET AL.

Art Unit

1634

SEARCHED

Class	Subclass	Date	Examiner
435	6 7.1 91.1	5/12/2006	m
	183		
	283.1		
	287.1		
	287.2		
436	94		
	501		
536	23.1 24.3 24.33 25.3		
530	300		
	350		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

STN	DATE	EXMR
East (see attached file)	5/12/2006	m

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner